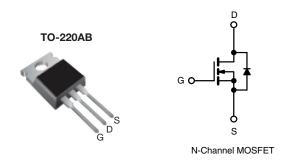


COMPLIANT

Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	60	60				
R _{DS(on)} (Ω)	V _{GS} = 5.0 V	0.10				
Q _g (Max.) (nC)	18	18				
Q _{gs} (nC)	4.5	4.5				
Q _{gd} (nC)	12	12				
Configuration	Sing	Single				



FEATURES

- Dynamic dV/dt Rating
- · Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS} = 4 V and 5 V
- 175 °C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC



Third generation Power MOSFETs from Vishay provides the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION				
Package	TO-220AB			
Lead (Pb)-free	IRLZ24PbF			
Leau (FD)-liee	SiHLZ24-E3			
SnPb	IRLZ24			
SIFD	SiHLZ24			

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	60		
Gate-Source Voltage			V_{GS}	± 10	- V	
Continuous Drain Current	V at 5.0 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	I-	17	А	
Continuous Drain Current	V _{GS} at 5.0 V	T _C = 100 °C	I _D	12		
Pulsed Drain Current ^a			I _{DM}	68		
Linear Derating Factor				0.40	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	64.1	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P _D	60	W	
Peak Diode Recovery dV/dt ^c	dV/dt	4.5	V/ns			
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	- °C	
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d		
Mauring Tayous	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 444 μ H, R_g = 25 Ω , I_{AS} = 17 A (see fig. 12).
- c. $I_{SD} \le 17$ A, $dI/dt \le 140$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	2.5		

PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static				•	•	•	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	to 25 °C, I _D = 1 mA	-	0.060	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		-	2.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 10		-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 6$	V _{DS} = 60 V, V _{GS} = 0 V		-	25	μΑ
Zero Gate Voltage Drain Current		V _{DS} = 48 V, V ₀	V _{DS} = 48 V, V _{GS} = 0 V, T _J = 150 °C		-	250	
Drain-Source On-State Resistance	В	V _{GS} = 5.0 V	I _D = 10 A ^b	-	-	0.10	Ω
Dialii-Source Oil-State nesistance	R _{DS(on)}	V _{GS} = 4.0 V	$I_D = 8.5 A^b$	-	-	0.14	
Forward Transconductance	g _{fs}	V _{DS} = 2	25 V, I _D = 10 A ^b	7.3	-	-	S
Dynamic							
Input Capacitance	C_{iss}	V	$r_{GS} = 0 \text{ V},$	-	870	-	pF
Output Capacitance	C _{oss}	V	os = 25 V,	-	360	-	
Reverse Transfer Capacitance	C_{rss}	f = 1.0 MHz, see fig. 5		-	53	-	1
Total Gate Charge	Q_g				-	18	
Gate-Source Charge	Q_{gs}	$V_{GS} = 5.0 \text{ V}$	$V_{GS} = 5.0 \text{ V}$ $I_D = 17 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 ^b	-	-	4.5	nC
Gate-Drain Charge	Q_{gd}		3	-	-	12	
Turn-On Delay Time	t _{d(on)}	V_{DD} = 30 V, I_{D} = 17 A, R_{g} = 9.0 Ω, R_{D} = 1.7 Ω, see fig. 10 ^b		-	11	-	ns
Rise Time	t _r			-	110	-	
Turn-Off Delay Time	t _{d(off)}			-	23	-	
Fall Time	t _f			-	41	-	
Internal Drain Inductance	L_D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	лU
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s			•	-	•	•
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	17	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	68	
Body Diode Voltage	V_{SD}	T _J = 25 °C, I ₅	_S = 17 A, V _{GS} = 0 V ^b	-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 17 A, dl/dt = 100 A/µs ^b		-	110	260	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.49	1.5	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-	n-on is do	minated b	by L _S and	L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

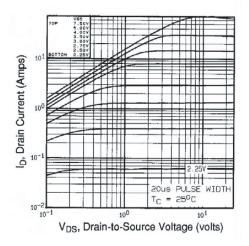


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

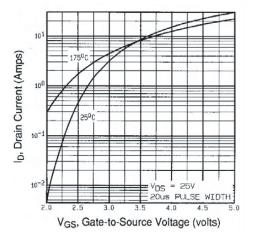


Fig. 3 - Typical Transfer Characteristics

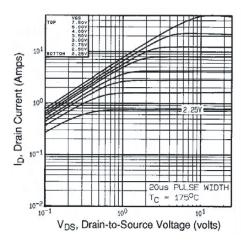


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

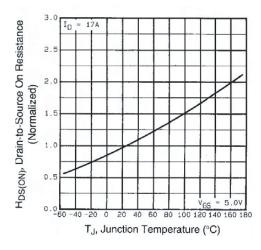


Fig. 4 - Normalized On-Resistance vs. Temperature



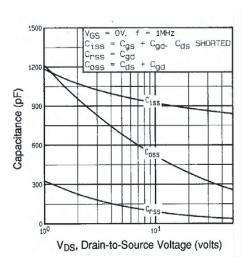


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

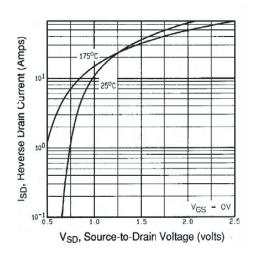


Fig. 7 - Typical Source-Drain Diode Forward Voltage

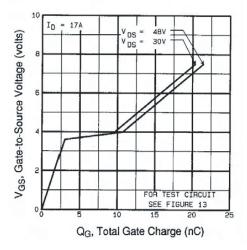


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

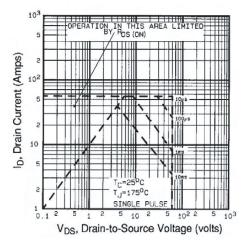


Fig. 8 - Maximum Safe Operating Area



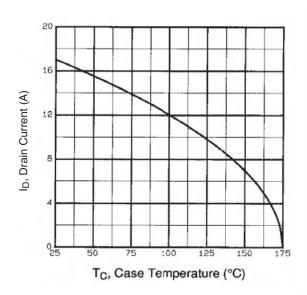


Fig. 9 - Maximum Drain Current vs. Case Temperature

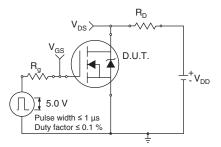


Fig. 10a - Switching Time Test Circuit

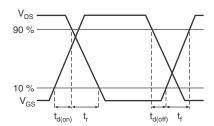


Fig. 10b - Switching Time Waveforms

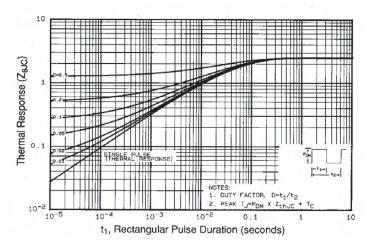
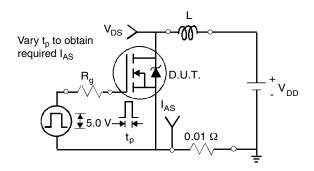


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





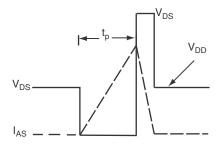


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

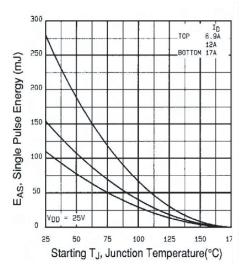


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

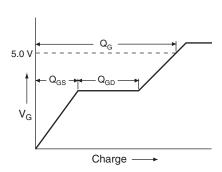


Fig. 13a - Basic Gate Charge Waveform

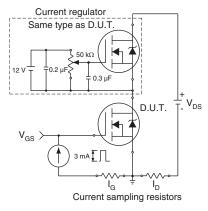
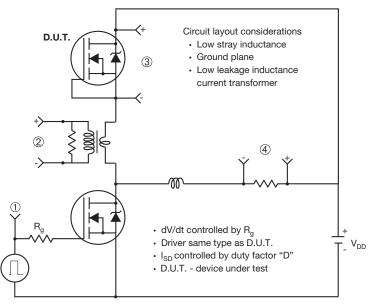


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



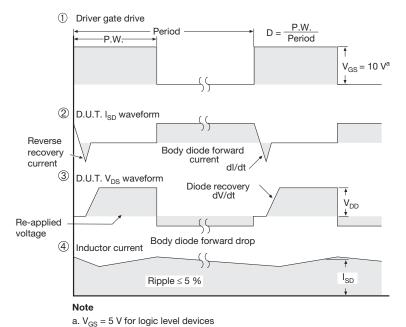


Fig. 14 - For N-Channel

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TO-220-1



DIM	MILLIN	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.24	4.65	0.167	0.183		
b	0.69	1.02	0.027	0.040		
b(1)	1.14	1.78	0.045	0.070		
С	0.36	0.61	0.014	0.024		
D	14.33	15.85	0.564	0.624		
E	9.96	10.52	0.392	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.10	6.71	0.240	0.264		
J(1)	2.41	2.92	0.095	0.115		
L	13.36	14.40	0.526	0.567		
L(1)	3.33	4.04	0.131	0.159		
ØР	3.53	3.94	0.139	0.155		
Q	2.54	3.00	0.100	0.118		
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031						

Note

 \bullet $M^{\star}=0.052$ inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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